

GSM2341

P-Channel Enhancement Mode MOSFET

Product Description

GSM2341, P-Channel enhancement mode MOSFET, uses Advanced Trench Technology to provide excellent $R_{DS(ON)}$, low gate charge.

These devices are particularly suited for low voltage power management, such as smart phone and notebook computer and other battery powered circuits, and low in-line power loss are needed in commercial industrial surface mount applications.

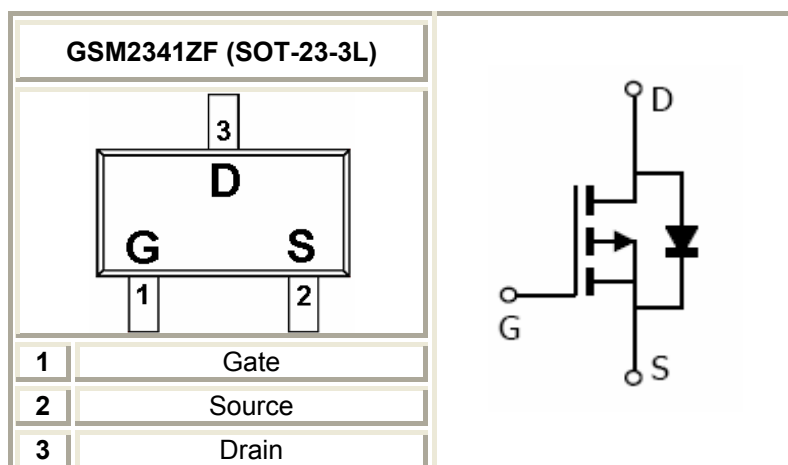
Features

- $-20V/-3.0A, R_{DS(ON)} = 50m\Omega @ V_{GS} = -4.5V$
- $-20V/-2.6A, R_{DS(ON)} = 64m\Omega @ V_{GS} = -2.5V$
- $-20V/-2.0A, R_{DS(ON)} = 80m\Omega @ V_{GS} = -1.8V$
- Super high density cell design for extremely low $R_{DS(ON)}$
- Exceptional on-resistance and maximum DC current capability
- SOT-23-3L package design

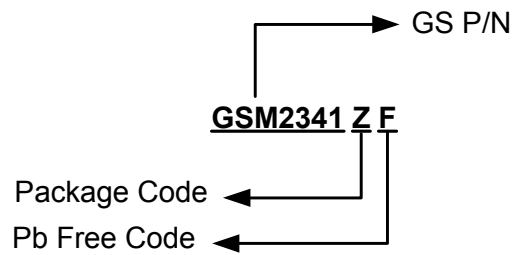
Applications

- Portable Equipment
- Battery Powered System
- Net Working System

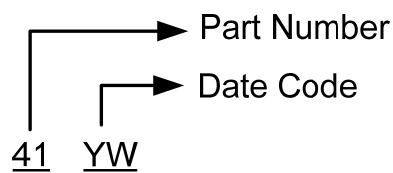
Packages & Pin Assignments



Ordering Information



Marking Information



Part Number	Package	Part Marking
GSM2341ZF	SOT-23-3L	41YW

※Week Code : A ~ Z (1 ~ 26) ; a ~ z (27 ~ 52)

Absolute Maximum Ratings

T_A=25°C Unless otherwise noted

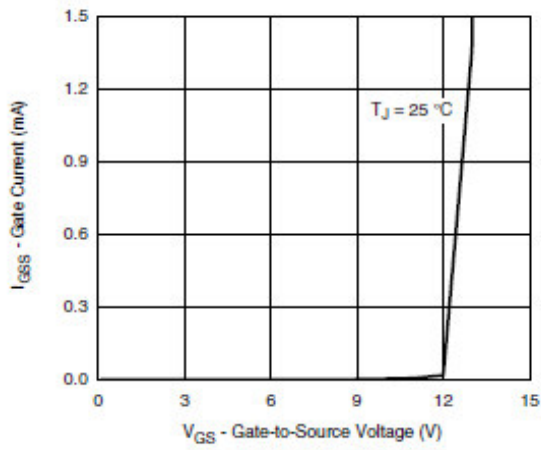
Symbol	Parameter	Typical	Unit
V _{DSS}	Drain-Source Voltage	-20	V
V _{GSS}	Gate -Source Voltage	±12	V
I _D	Continuous Drain Current(T _J =150°C)	T _A =25 °C	-3.0
		T _A =70 °C	-2.6
I _{DM}	Pulsed Drain Current	-10	A
I _S	Continuous Source Current(Diode Conduction)	-1.6	A
P _D	Power Dissipation	T _A =25 °C	1.25
		T _A =70 °C	0.8
T _J	Operating Junction Temperature	150	°C
T _{STG}	Storage Temperature Range	-55/150	°C
R _{θJA}	Thermal Resistance-Junction to Ambient	120	°C/W

Electrical Characteristics

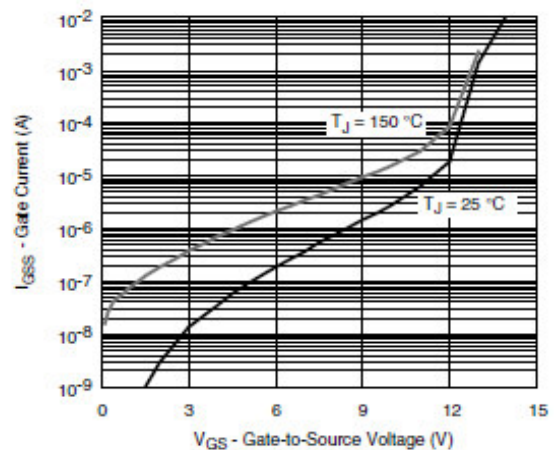
T_A=25°C Unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250uA	-20			V
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250uA	-0.4		-0.8	
I _{GSS}	Gate Leakage Current	V _{DS} =0V, V _{GS} =±12V			±100	nA
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-16V, V _{GS} =0V			-1	uA
		V _{DS} =-16V, V _{GS} =0V T _J =85°C			-10	
I _{D(on)}	On-State Drain Current	V _{DS} ≥ -5V, V _{GS} =-4.5V	-6			A
		V _{DS} ≥ -5V, V _{GS} =-2.5V	-4			
R _{DS(on)}	Drain-Source On-Resistance	V _{GS} = -4.5V, I _D =-3.0A		45	50	mΩ
		V _{GS} = -2.5V, I _D =-2.6A		56	64	
		V _{GS} = -1.0V, I _D =-2.0A		70	80	
g _{FS}	Forward Transconductance	V _{DS} =-5V, I _D =-3.6A		10		S
V _{SD}	Diode Forward Voltage	I _S =-1.6A, V _{GS} =0V		-0.85	-1.2	V
Dynamic						
Q _g	Total Gate Charge	V _{DS} =-10V, V _{GS} =-4.5V, I _D =-4.0A		8	12	nC
Q _{gs}	Gate-Source Charge			0.9		
Q _{gd}	Gate-Drain Charge			3.0		
C _{iss}	Input Capacitance	V _{DS} =-10V, V _{GS} =0V, f=1MHz		780		pF
C _{oss}	Output Capacitance			115		
C _{rss}	Reverse Transfer Capacitance			55		
t _{d(on)}	Turn-On Time	V _{DD} =-10V, R _L =2.3Ω, I _D =-4.0A, V _{GEN} =-4.5V, R _G =-1Ω		0.2	0.3	us
t _r				1.0	1.5	
t _{d(off)}	Turn-Off Time			4.0	6.0	
t _f				2.0	3.0	

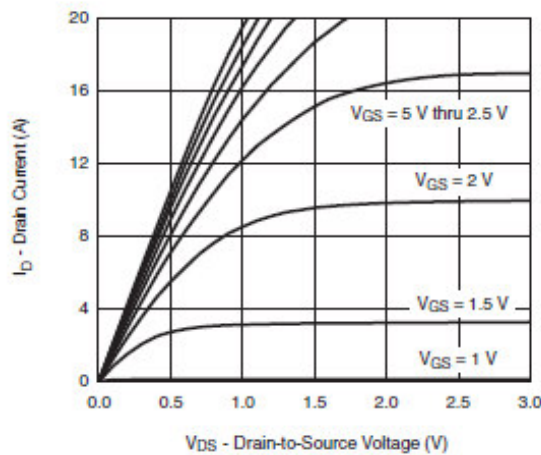
Typical Performance Characteristics



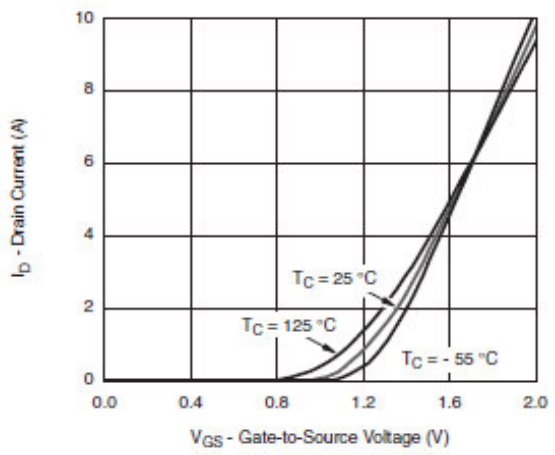
Gate Current vs. Gate-Source Voltage



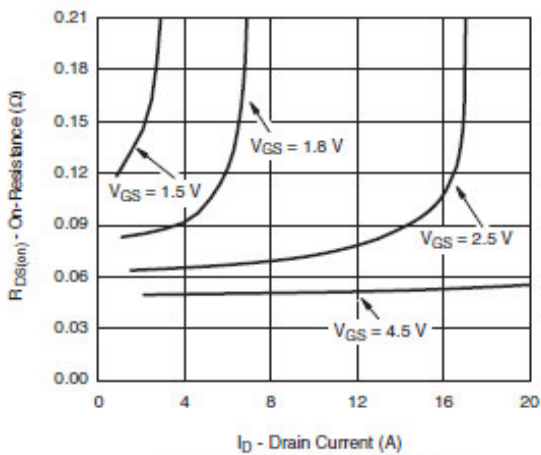
Gate Current vs. Gate-Source Voltage



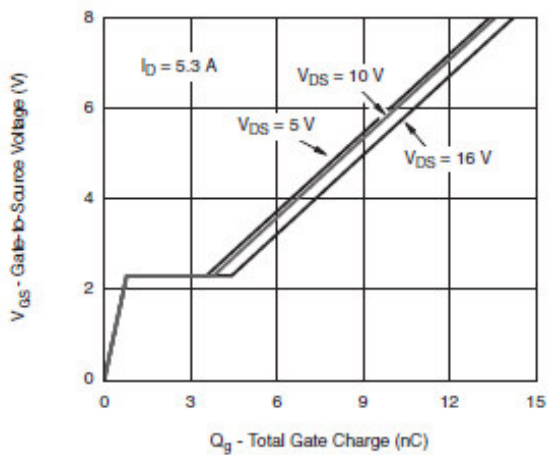
Output Characteristics



Transfer Characteristics

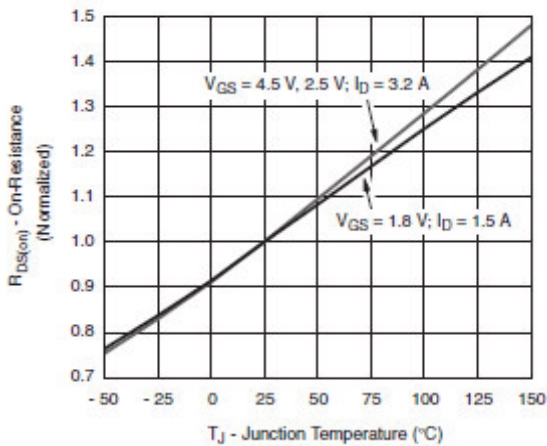


On-Resistance vs. Drain Current

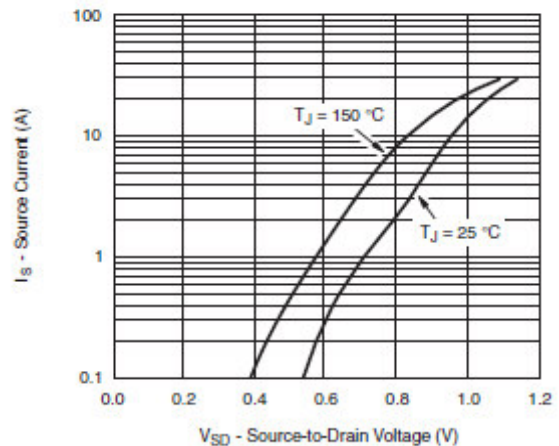


Gate Charge

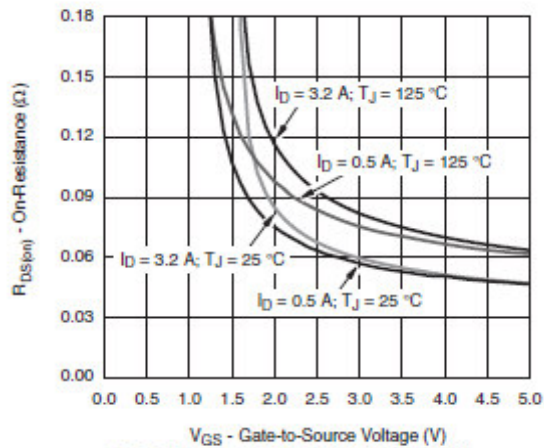
Typical Performance Characteristics



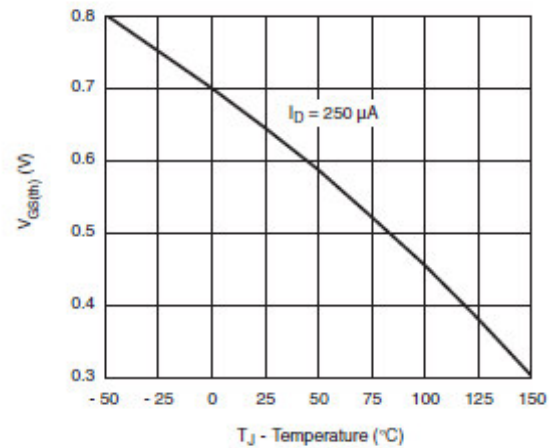
On-Resistance vs. Junction Temperature



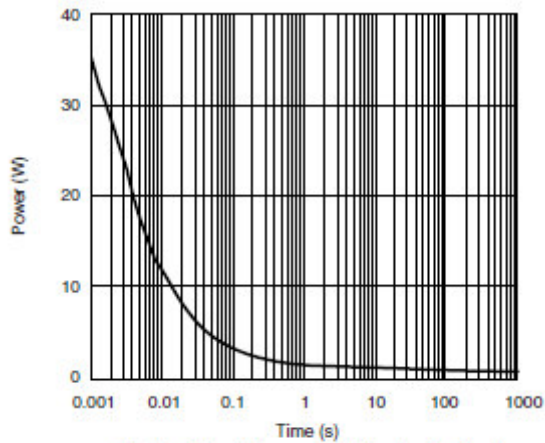
Source-Drain Diode Forward Voltage



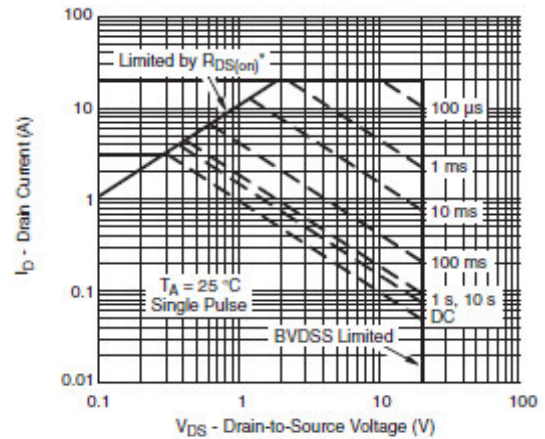
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



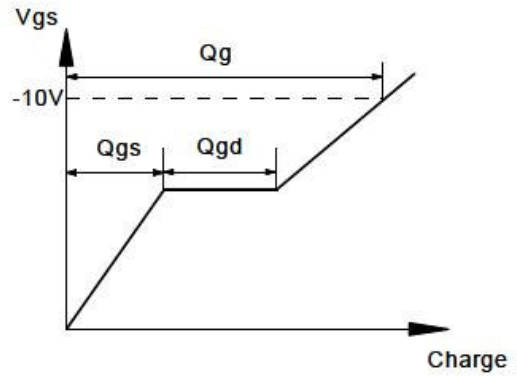
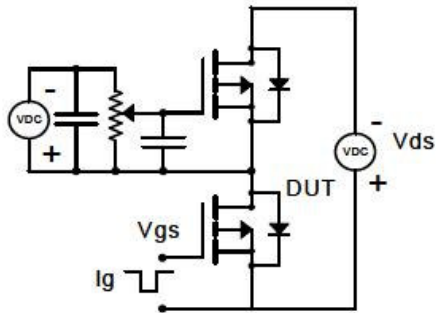
Single Pulse Power, Junction-to-Ambient



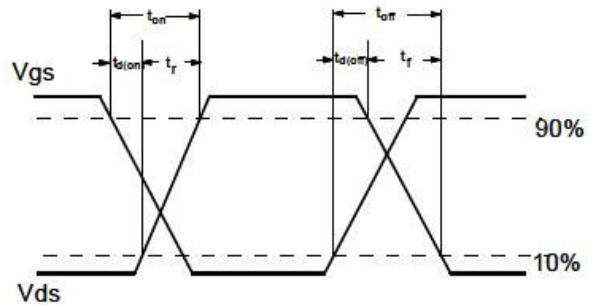
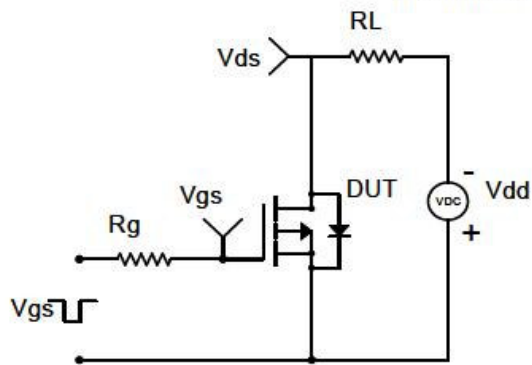
Safe Operating Area, Junction-to-Ambient

Typical Performance Characteristics

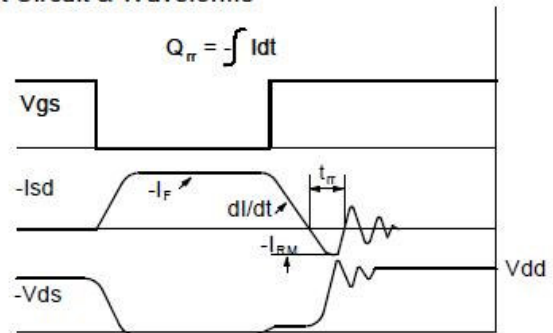
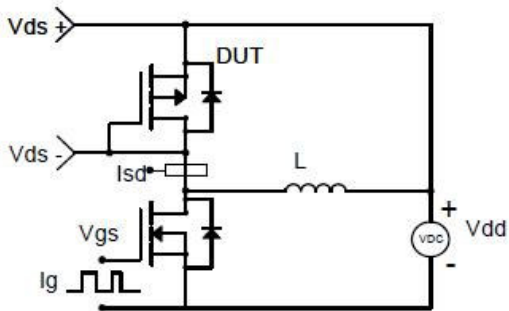
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms

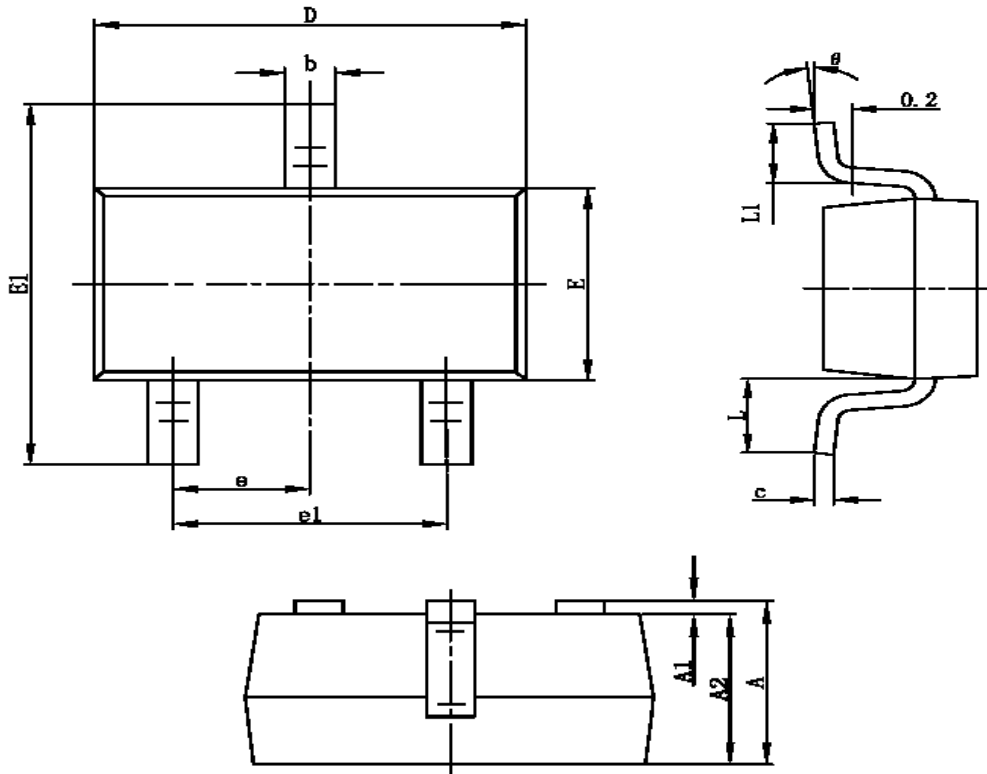


Diode Recovery Test Circuit & Waveforms



Package Dimension

SOT-23-3L







Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.400	0.012	0.016
c	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E	1.500	1.700	0.059	0.067
E1	2.400	2.950	0.104	0.116
e	0.950TYP		0.037TYP	
e1	1.800	2.000	0.071	0.079
L	0.700REF		0.028REF	
L1	0.300	0.600	0.012	0.024
θ	0 °C	8 °C	0 °C	8 °C



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